

<b>Notice of References Cited</b>	Application/Control No. 10/611,295	Applicant(s)/Patent Under Reexamination SHEI, STEVEN M.	
	Examiner Joseph M Pelham	Art Unit 3742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,374,319	02-1983	Guibert, Raul	219/400
	B	US-4,587,946	05-1986	Doyon et al.	126/20
	C	US-4,381,442	04-1983	Guibert, Raul	219/400
	D	US-5,699,722	12-1997	Erickson et al.	99/330
	E	US-6,710,308	03-2004	Sauter et al.	219/490
	F	US-2003/0047553	03-2003	Patti et al.	219/400
	G	US-6,450,085	09-2002	Riesselmann, Gottfried	99/327
	H	US-6,545,251	04-2003	Allera et al.	219/394
	I	US-6,412,403	07-2002	Veltrop, Loren J.	99/483
	J	US-6,658,994	12-2003	McMillan, Thomas A.	99/468
	K	US-5,852,967	12-1998	Fortmann et al.	99/483
	L	US-2,964,609	12-1960	ANOFF SEYMOUR M	219/394
	M	US-2,860,225	11-1958	AUGUST STEEN CARL	99/389

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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